

Search Notes

Application/Control No.

10/531,329

Examiner

Diem Tran

Applicant(s)/Patent under
Reexamination

HIRANUMA ET AL.

Art Unit

3748

SEARCHED

Class	Subclass	Date	Examiner
60	276	1/5/07	DT
↓	295	↓	↓
↓	297	↓	↓
↓	311	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR